# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination DORN, JURGEN Examiner | Art Unit | Page 1 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,576,534 A	03-1986	Barth et al.	411/412
*	В	US-4,580,568 A	04-1986	Gianturco, Cesare	606/198
*	С	US-5,619,878 A	04-1997	Grosjean et al.	72/56
*	D	US-5,697,948 A	12-1997	Marin et al.	606/198
*	Е	US-5,749,880 A	05-1998	Banas et al.	606/198
*	F	US-5,776,141 A	07-1998	Klein et al.	623/1.11
*	G	US-5,876,448 A	03-1999	Thompson et al.	623/1.13
*	Н	US-5,928,258 A	07-1999	Khan et al.	606/191
*	1	US-5,920,975 A	07-1999	Morales, Stephen A.	29/282
*	J	US-6,063,092 A	05-2000	Shin, Mark Young	606/108
*	К	US-6,143,014 A	11-2000	Dehdashtian et al.	606/192
*	L	US-6,214,039 B1	04-2001	Banas et al.	623/1.13
*	М	US-2001/0039446 A1	11-2001	EDWIN et al.	623/1.13

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				,	
	0					
	Р					
	Q					
	R	-				
	s	,				
	Т					

## **NON-PATENT DOCUMENTS**

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U						
	V						
	w						
	×						

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination DORN, JURGEN Examiner | Art Unit | Page 2 of 3

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0038143 A1	03-2002	McCrea et al.	623/1.13
*	В	US-2002/0029076 A1	03-2002	Yee, Carl E.	623/1.11
*	С	US-2002/0058993 A1	05-2002	Landau et al.	623/1.35
*	D	US-6,451,047 B2	09-2002	McCrea et al.	623/1.13
*	Ε	US-6,471,718 B1	10-2002	Staehle et al.	623/1.11
*	F	US-2002/0147490 A1	10-2002	Pletzer et al.	623/1.11
*	G	US-2002/0193863 A1	12-2002	Rourke et al.	623/1.11
*	н	US-2003/0032999 A1	02-2003	Huang, Mark	623/1.11
*	1	US-6,607,551 B1	08-2003	Sullivan et al.	623/1.11
*	J	US-6,613,075 B1	09-2003	Healy et al.	623/1.11
*	к	US-2004/0106977 A1	06-2004	Sullivan et al.	623/001.12
*	L	US-6,758,858 B2	07-2004	McCrea et al.	623/1.13
*	, м	US-6,776,791 B1	08-2004	Stallings et al.	623/1.11

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т			•	·	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	υ							
	٧							
	w							
	×							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/552,886 DORN, JURGEN Examiner Eric Blatt Art Unit 3709 Page 3 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,796,998 B2	09-2004	Schaldach et al.	623/1.15
*	В	US-2004/0204749 A1	10-2004	Gunderson, Richard	623/001.12
*	C(	US-6,858,034 B1	02-2005	Hijlkema et al.	606/108
*	D	US-6,945,989 B1	09-2005	Betelia et al.	623/1.11
*	E	US-7,011,675 B2	03-2006	Hemerick et al.	623/1.12
*	F	US-2006/0184225 A1	08-2006	Pryor, Jack	623/001.11
*	G	US-2006/0184226 A1	08-2006	Austin, Michael	623/001.11
*	Н	US-2006/0216404 A1	09-2006	Seyler et al.	427/002.1
*	1	US-2007/0156251 A1	07-2007	Karmon, Ben-Zion	623/023.61
	J	US-			
	К	US-			
	L	US-			
	М	US-			

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	s					
	Т					-

### **NON-PATENT DOCUMENTS**

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	٧			
	w			
	×			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.